Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination LEIDEN ET AL.	
09/473,830		
Examiner	Art Unit	
Shin-Lin Chen	1632	

SEARCHED						
Class	Subclass	Date	Examiner			
Updated		11/28/2005	4n			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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